## Notice of References Cited Application/Control No. 10/806,914 Examiner (Nancy) Thanh-Nhan P. Nguyen Applicant(s)/Patent Under Reexamination IKEDA ET AL. Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,552,764	04-2003	Fujioka et al.	349/106
	В	US-			
	С	US-			
	D	US-			
	Е	US-			
	F	US-		·	
	G	US-			
	Н	US-			
	1	US-			
	J	US-			
	К	US-			
	L	US-			
	M	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q		1/			
	R					
	S					
	Т	,		100000000000000000000000000000000000000		

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	·
jir 1	٧	
	w	
	x	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.